

Application of Electron Microscopy Techniques to the Investigation of Space Shuttle Columbia Accident

SEMS 2005

By

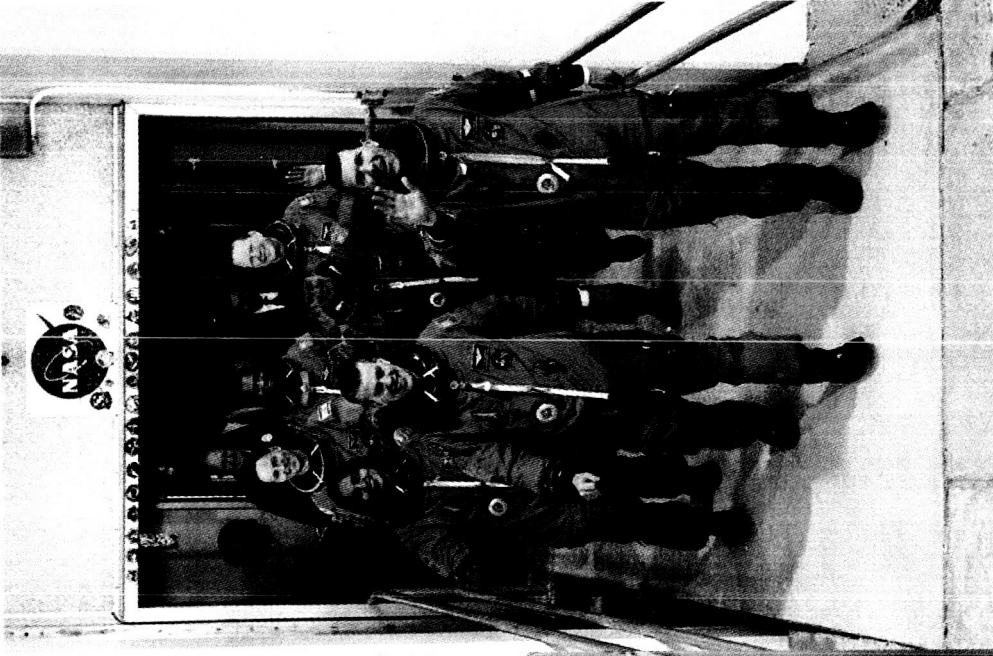
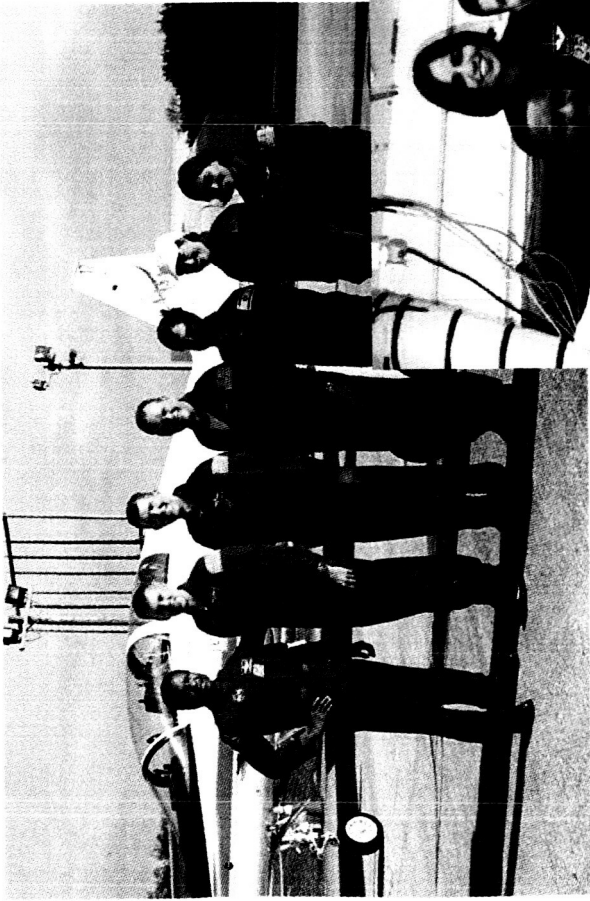
Dr. Sandeep Shah

Lead, Materials Diagnostics Team, NASA MSFC

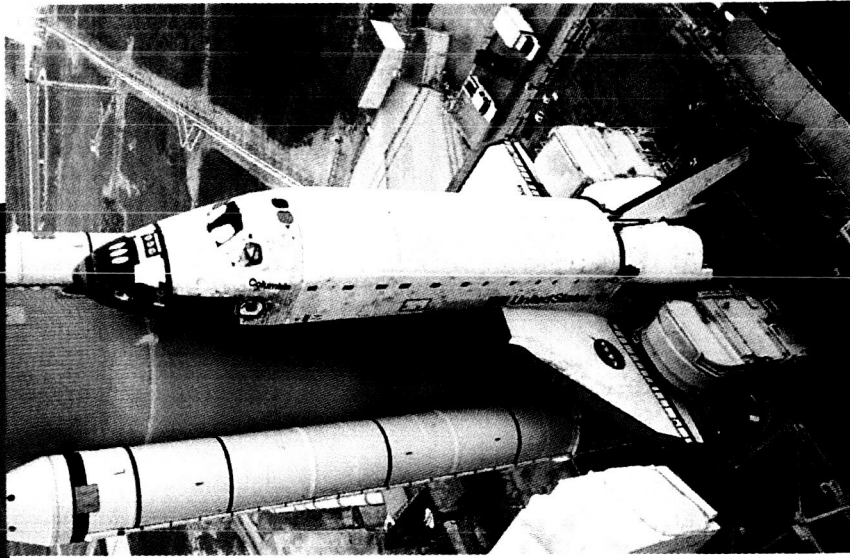
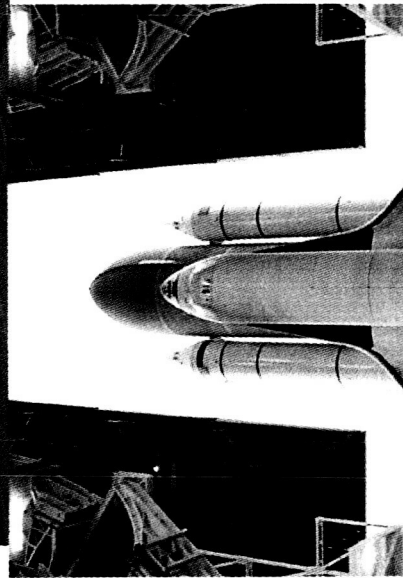
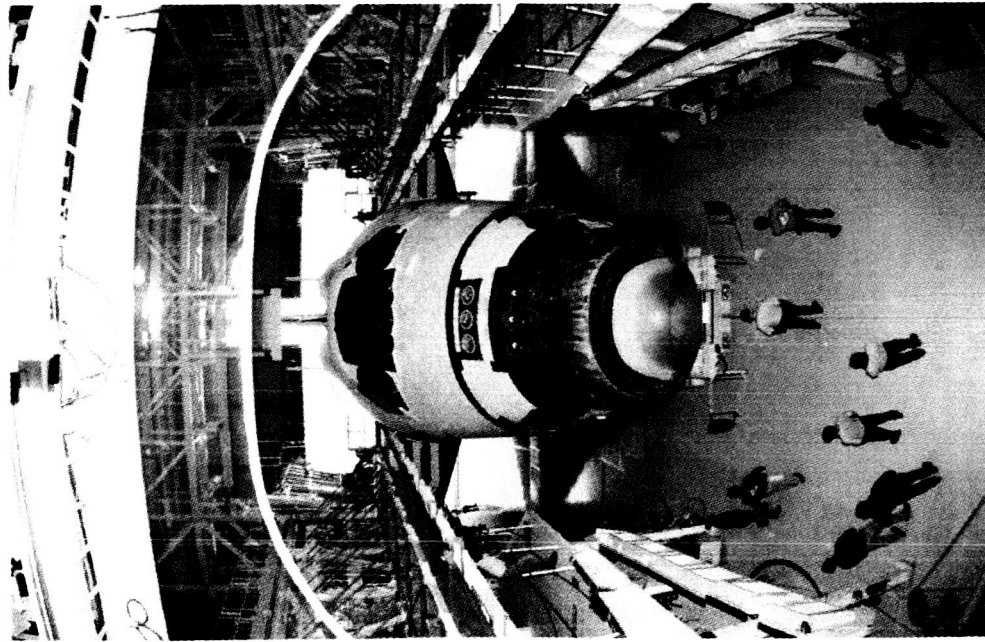
256-544-0836, sandeep.r.shah@nasa.gov

May 19th, 2005

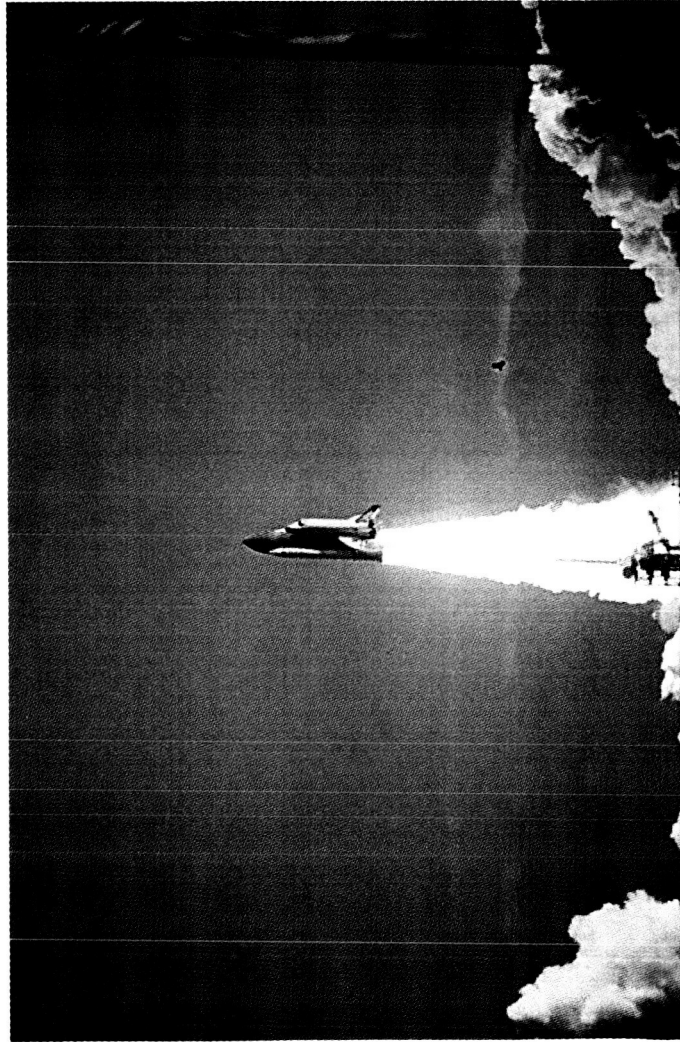
Acknowledgement: This work is a result of a team effort involving KSC, JSC, MSFC, LaRC, GRC, Boeing, USA and Columbia Accident Investigation Board personnel.¹



IN MEMORY
OF STS-107
ASTRONAUTS



Space Shuttle Columbia
Roll Out



Debris forward of LH wing leading edge

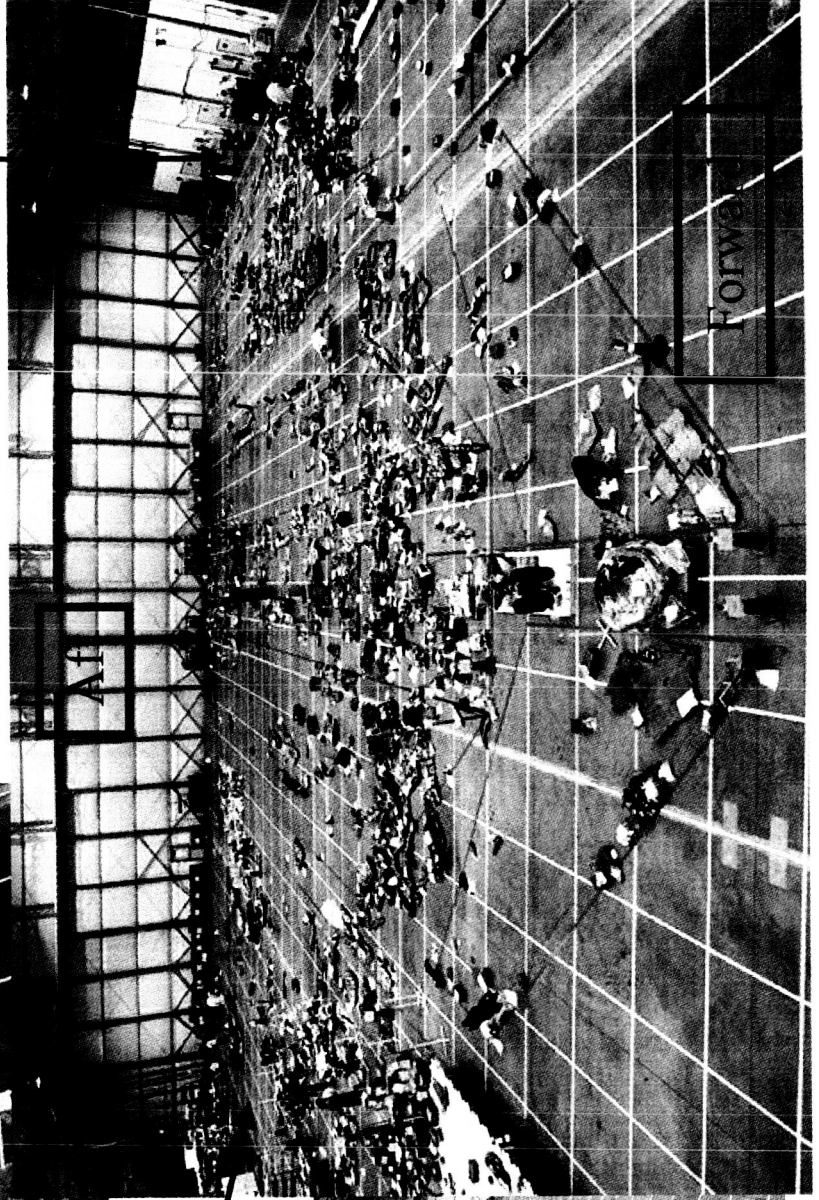


Two pieces of debris

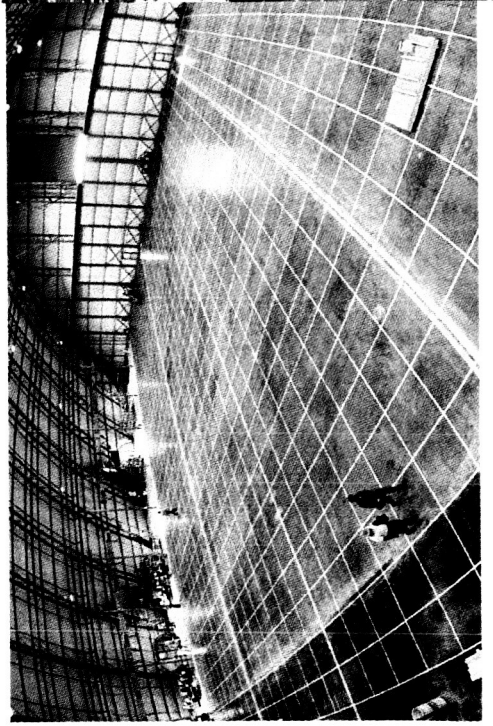
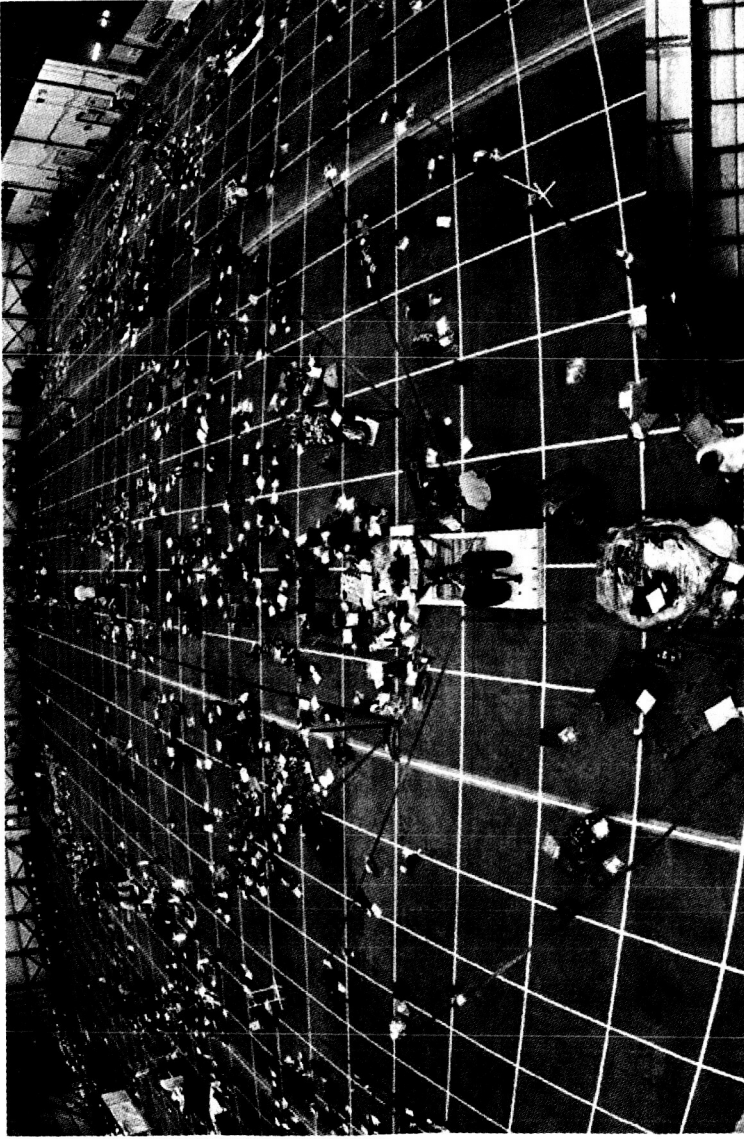
STS107 Launch

STS107 Reconstruction - Wing
and Underbelly Surfaces Only

Right Wing



Left Wing

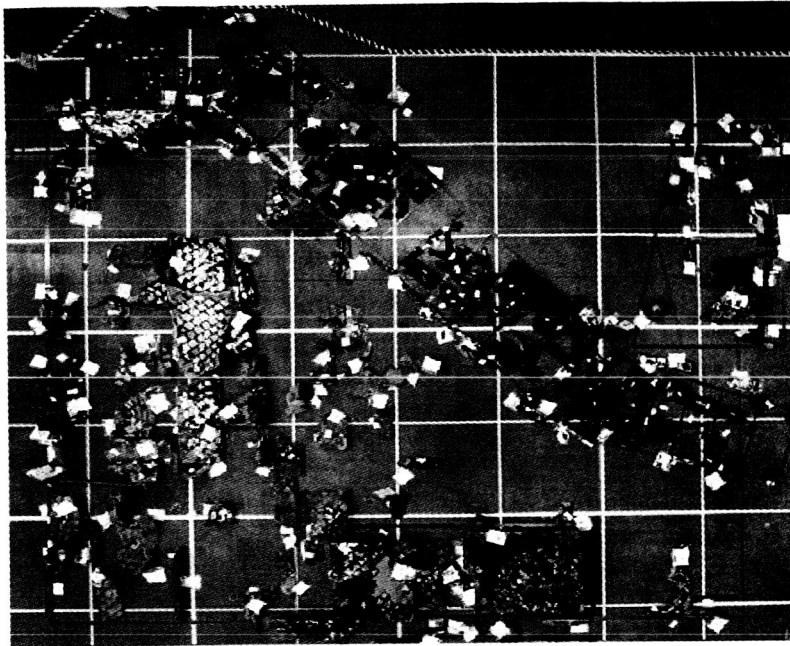




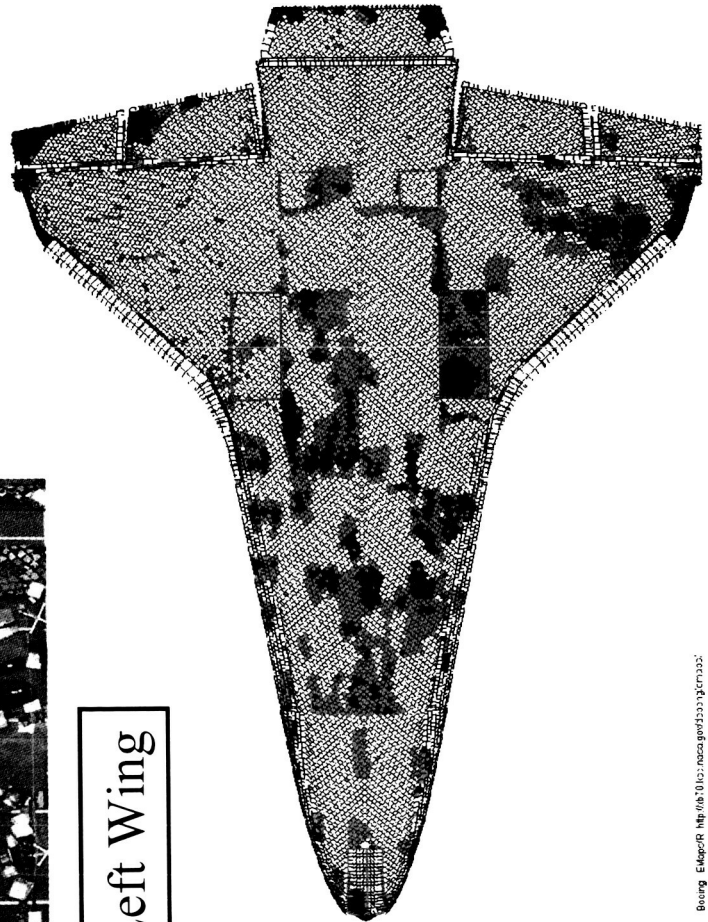
Every part numbered and tracked in database.



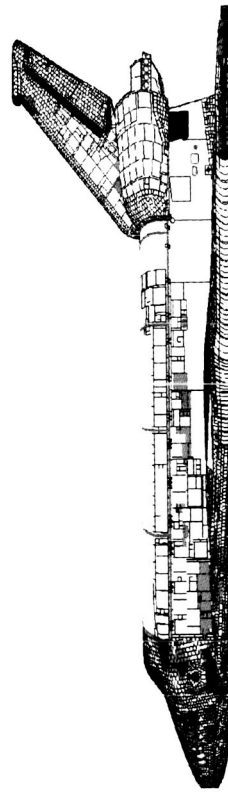
Left Wing



Right Wing



Boeing EMap®R <http://a.ti.ti.com/nasa/god3333/cr3332/>



Boeing EMap®R <http://a.ti.ti.com/nasa/god3333/cr3332/>

Failure Analysis Challenges

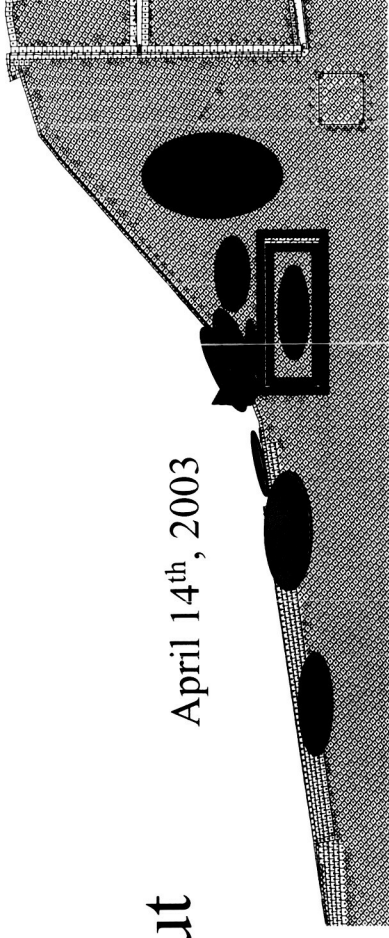
- Where to Begin? What Questions to ask?
- How many parts to analyze?
- Priority of each Failure Analysis?
- Distinguish between damage in flight vs free fall and impact.

M&P Team to provide Factual data about materials condition.

Failure Analysis Locations

- All indications of Left Wing Failure. Where??
- Initial Analysis focused on multiple Left Wing parts:

- Midbody Panel
- Main Landing Gear Strut
- Uplock Rollers
- Tires
- Leading Edge Carrier Panel Fasteners
- Tiles
- Leading edge RCC material deposit



Key Finding

- Data Recorder Found—“black box” .
- Black box showed increase in temperature in left wing leading edge prior to any other sensor failure indicating a possible breach.

Spotlight/focus shifts to Left Wing Leading
Edge damage

Location of each part found tracked on map - Trend emerges.



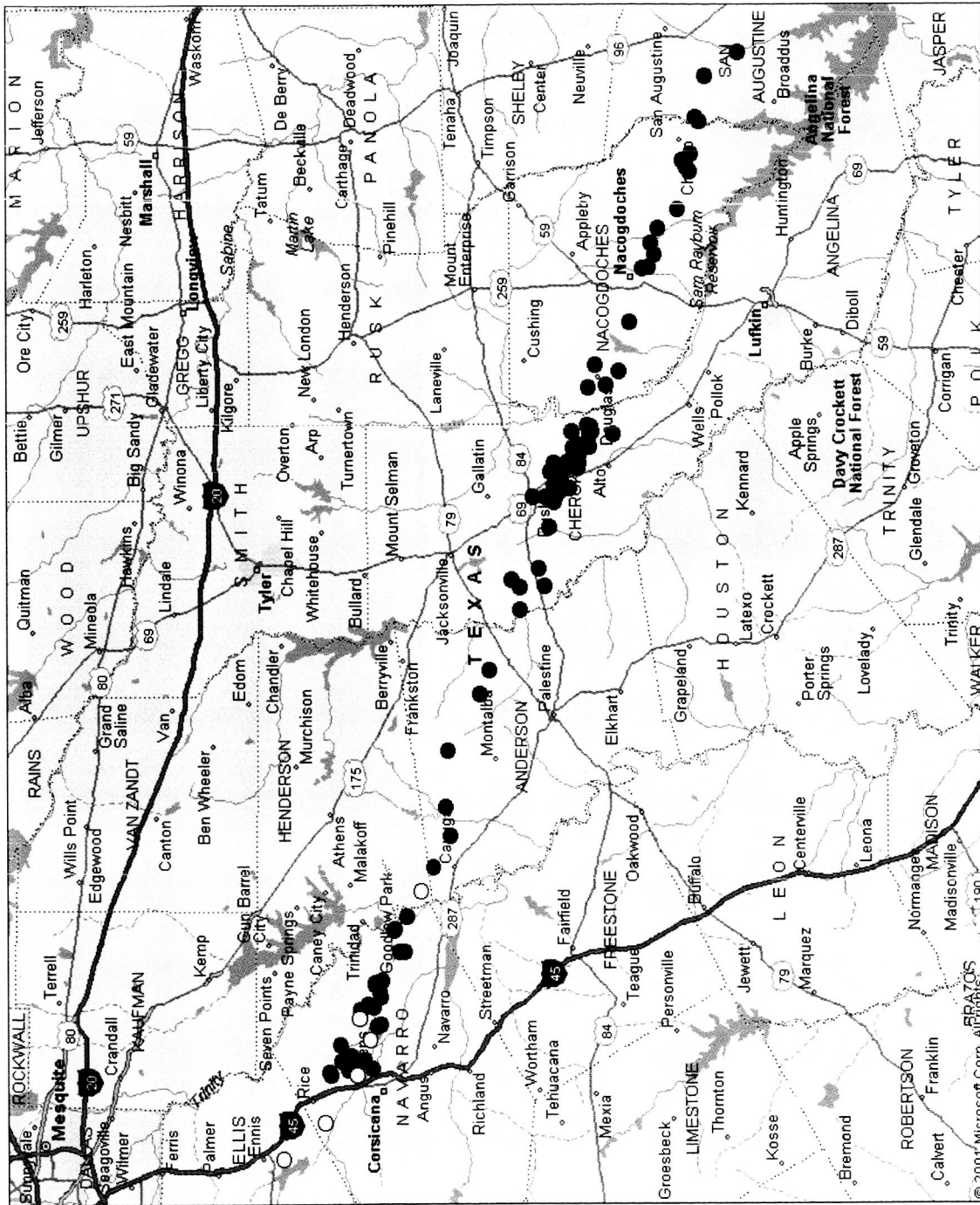
Left Wing
RCC



Left Wing
Eroded RCC



Right Wing
RCC



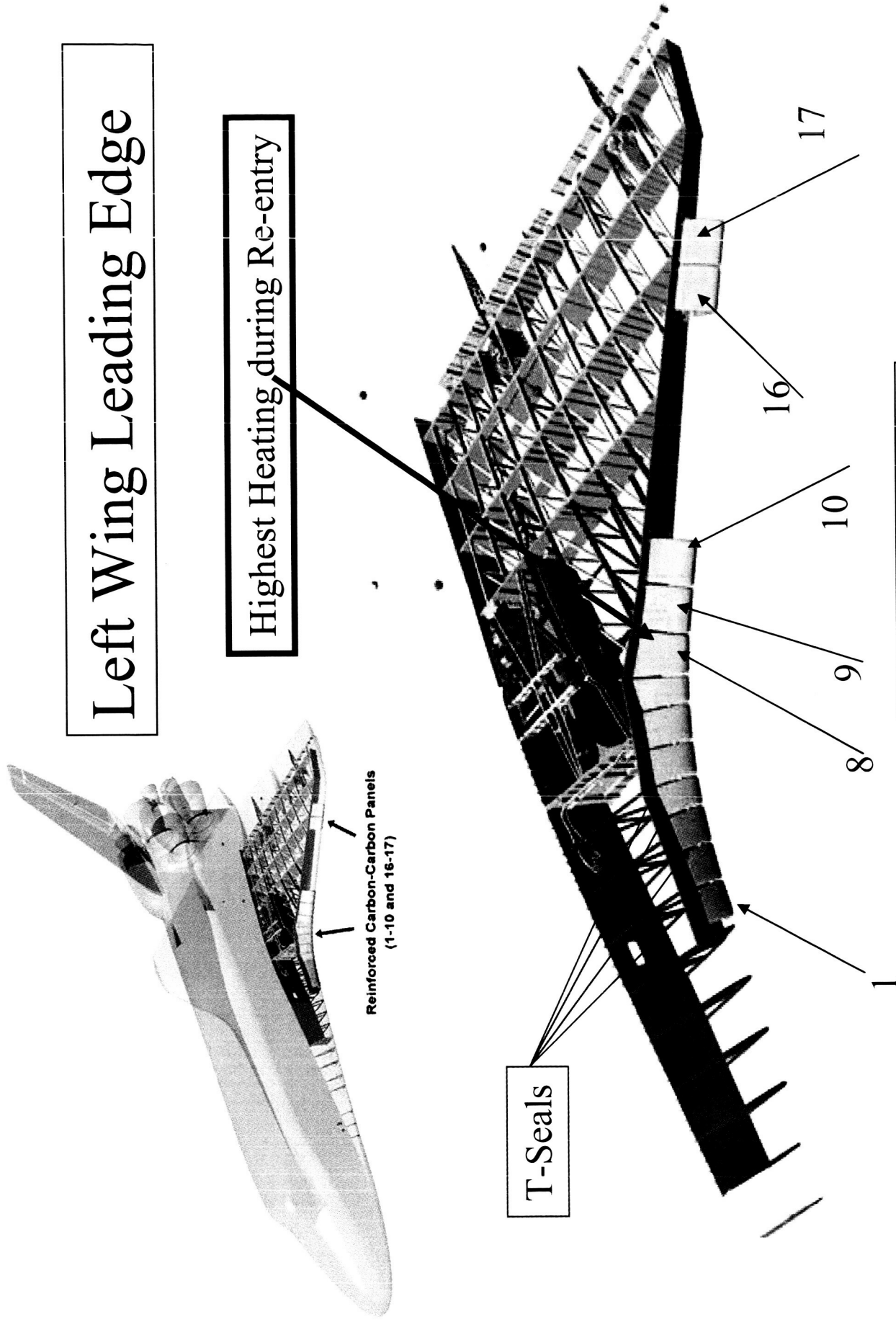
Left Wing Leading Edge

Highest Heating during Re-entry

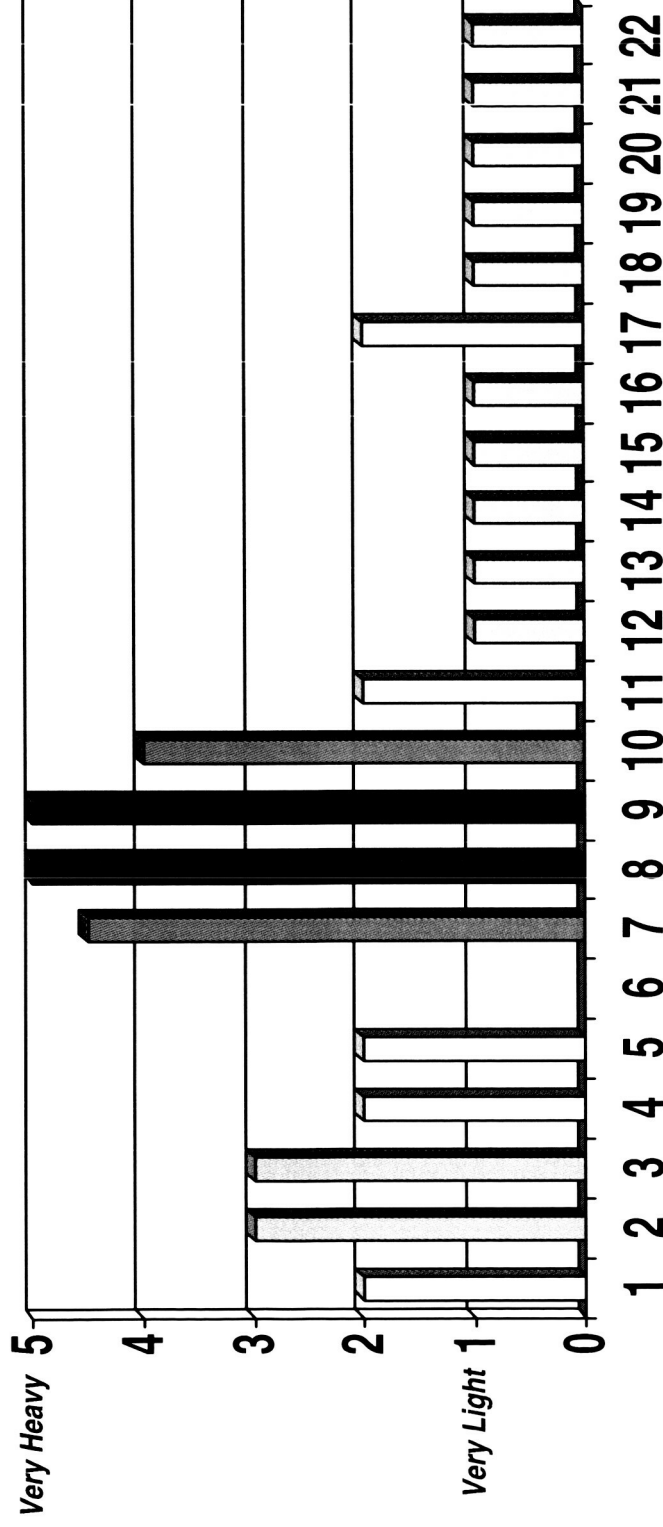
Reinforced Carbon-Carbon Panels
(1-10 and 16-17)

T-Seals

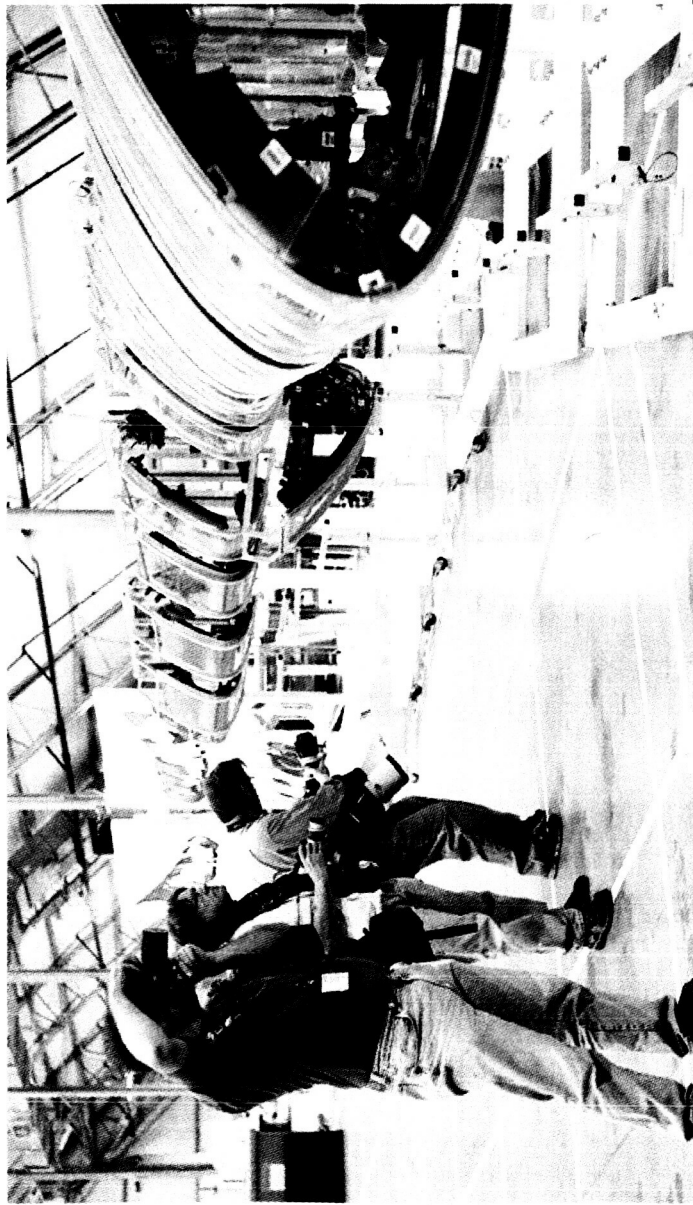
RCC Panel Numbers



Qualitative Slag Deposition Assessment “Very Light” to “Very Heavy”



Distribution of “slag” deposition volume
was centered around panels 8 & 9 on Left Wing Leading
Edge RCC.

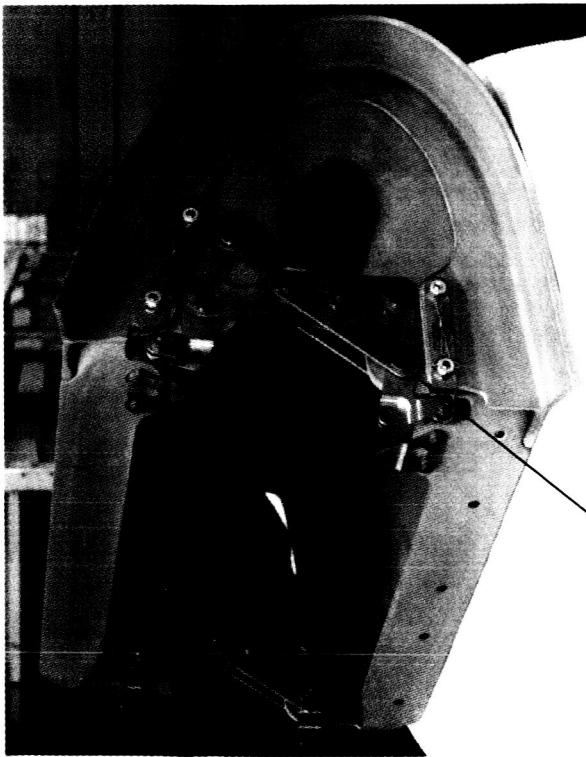


Left Wing Leading Edge
Final 3D Reconstruction

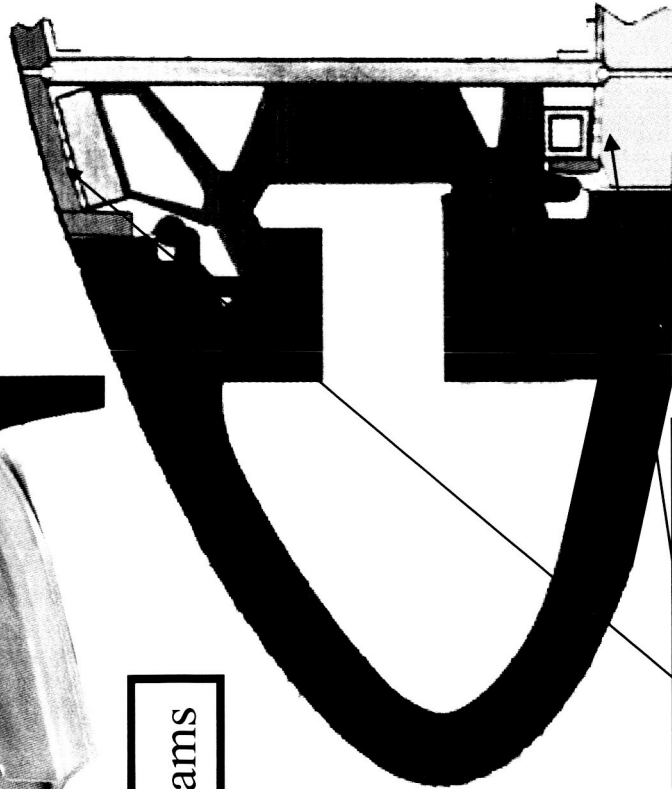


Left Wing Tile
Reconstruction

Leading Edge Tiles



Spanner Beams

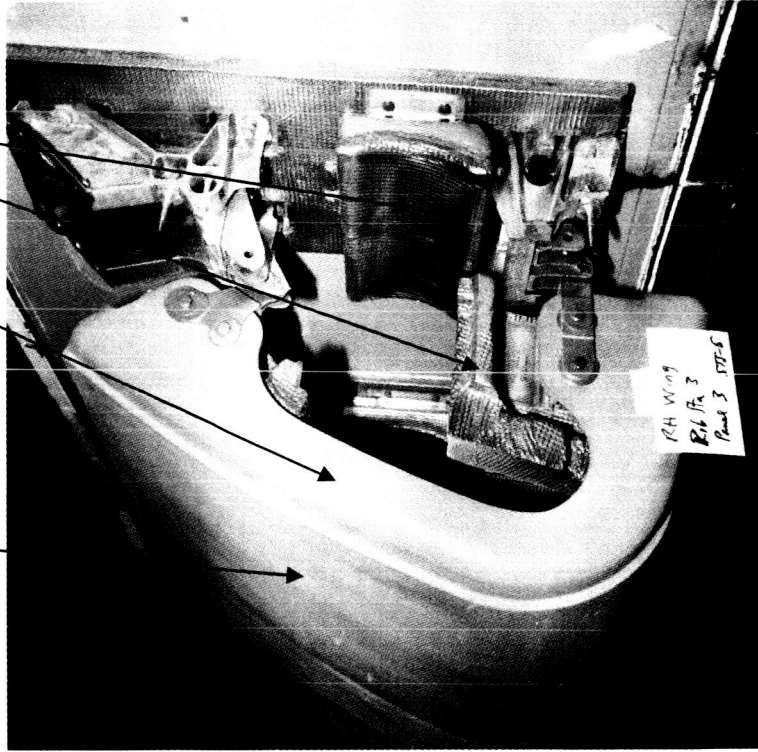




Closeout/Carrier Panels and Tiles

Dynaflex insulation – In601 foil with cerachrome fibers inside

RCC panel

RCC rib



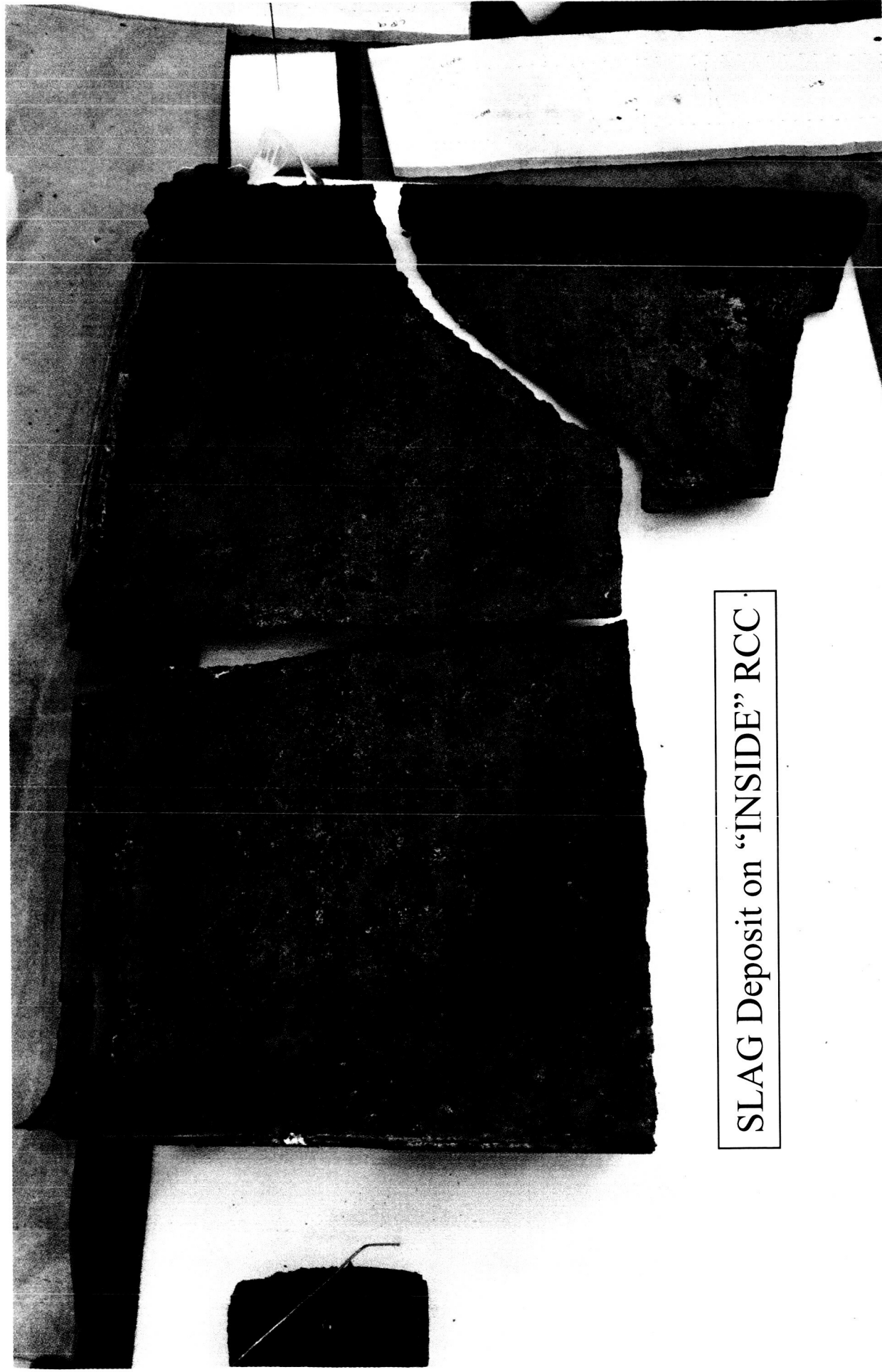
-  RCC
-  Aluminum
-  LI2200
-  LI900
-  Inconel-Dynaflex
-  Inconel 718
-  A-286 steel

Major Wing Leading Edge Materials and compositions

Insulators	IN601, Cerachrome	Ni-24Cr-14Fe-3Al-5Co-0.3Mn, Al ₂ O ₃ +SiO ₂ +Cr ₂ O ₃ (3200F)
Insulator Clip	Inconel 625	Max Ox resistance temp-1925F, Melting Point-2400F
RCC Clevis	Inconel 718	
Clevis Bracket	Inconel 625	Atomic: Ni-25Cr-3Fe-0.25Ti-0.5Al-5.6Mo-2.3Nb-Co-Mn
Insulator Strap	Inconel 718	
Fitting - Adjustable	A-286	
Spanner Beam	Inco 718	Max Ox resistance temp-1800F, Melting Point-2550F
Tee Clevis	Inco 718	Atomic Comp: Ni-21Cr-19Fe-1Ti-1Al-2Mo-3-Nb-5Co
Wick Plate	INCO A-750	
Shear Fitting/Wick	Inco 718	
Shear Pin/Ratchet	A-286	Max Ox resistance temp-1500F, Melting Point-2550F
Spar Attach Fitting	A-286	Atomic Comp: Fe-24Ni-16Cr-2.5Ti-0.7Al-0.8Mo-1Mn-0.33V
Spar	2024	MP-1200, Al-1.92Cu-1.71Mg-0.3Mn
Tiles	SiO ₂	SiO ₂
Gap Filler	Al ₂ O ₃ , Nextel	Al ₂ O ₃
Bond Material	RTV, Nomex Felt	
Carrier Panel	2024 + 6061	
CP Fasteners	A286	

IN625, IN601, IN718, A286, 2024, Cerachrome,
SiO₂, 6061, Nextel Fabric, RTV

Example Debris, LH RCC 8



SLAG Deposit on "INSIDE" RCC

High Level Questions to M&P

Sample the slag deposits on RCC & Tiles to:

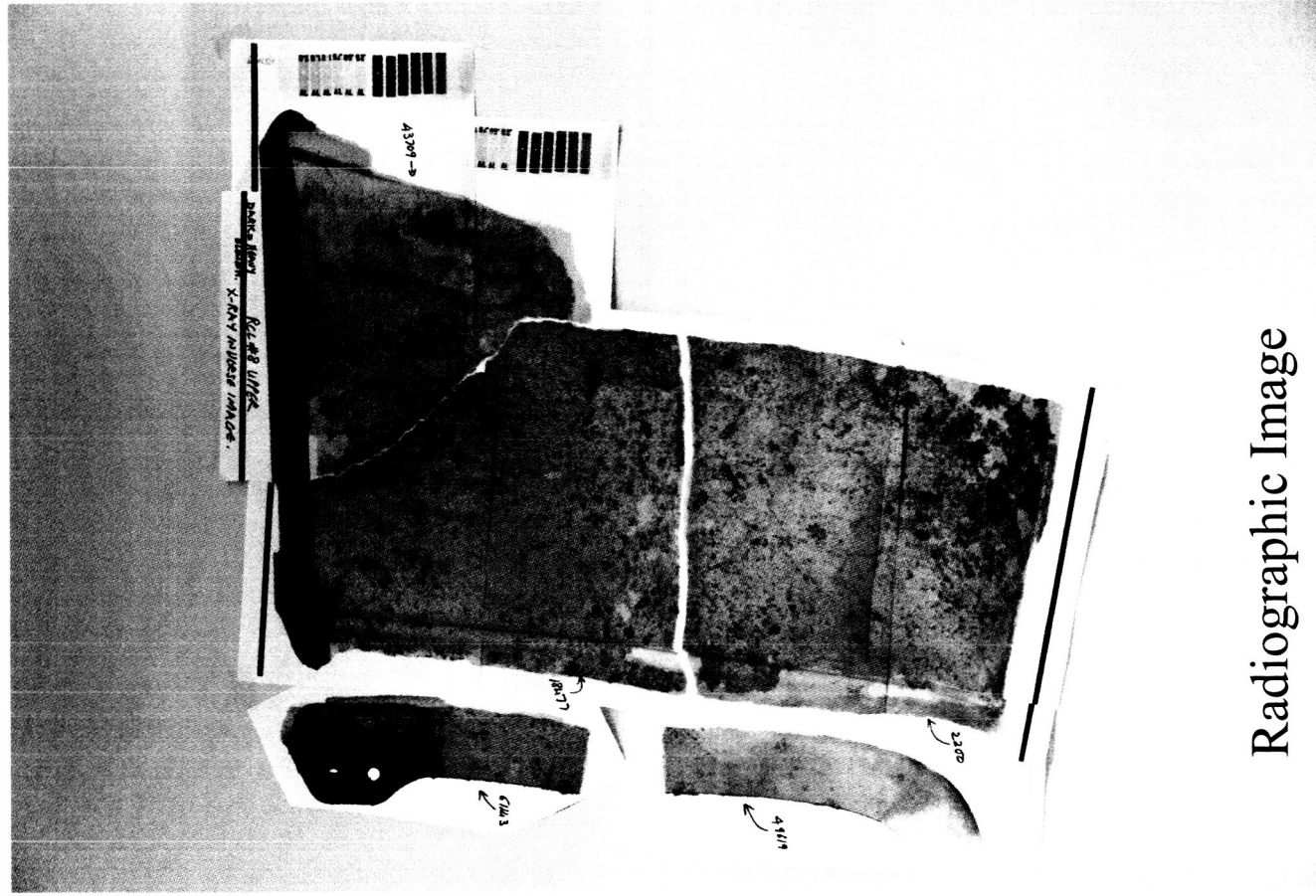
- Identify the location of breach in the wing leading edge.
- Identify the sequence of deposition/events
- Understand plasma flow direction and related thermal damage.

Analysis Techniques Arsenal

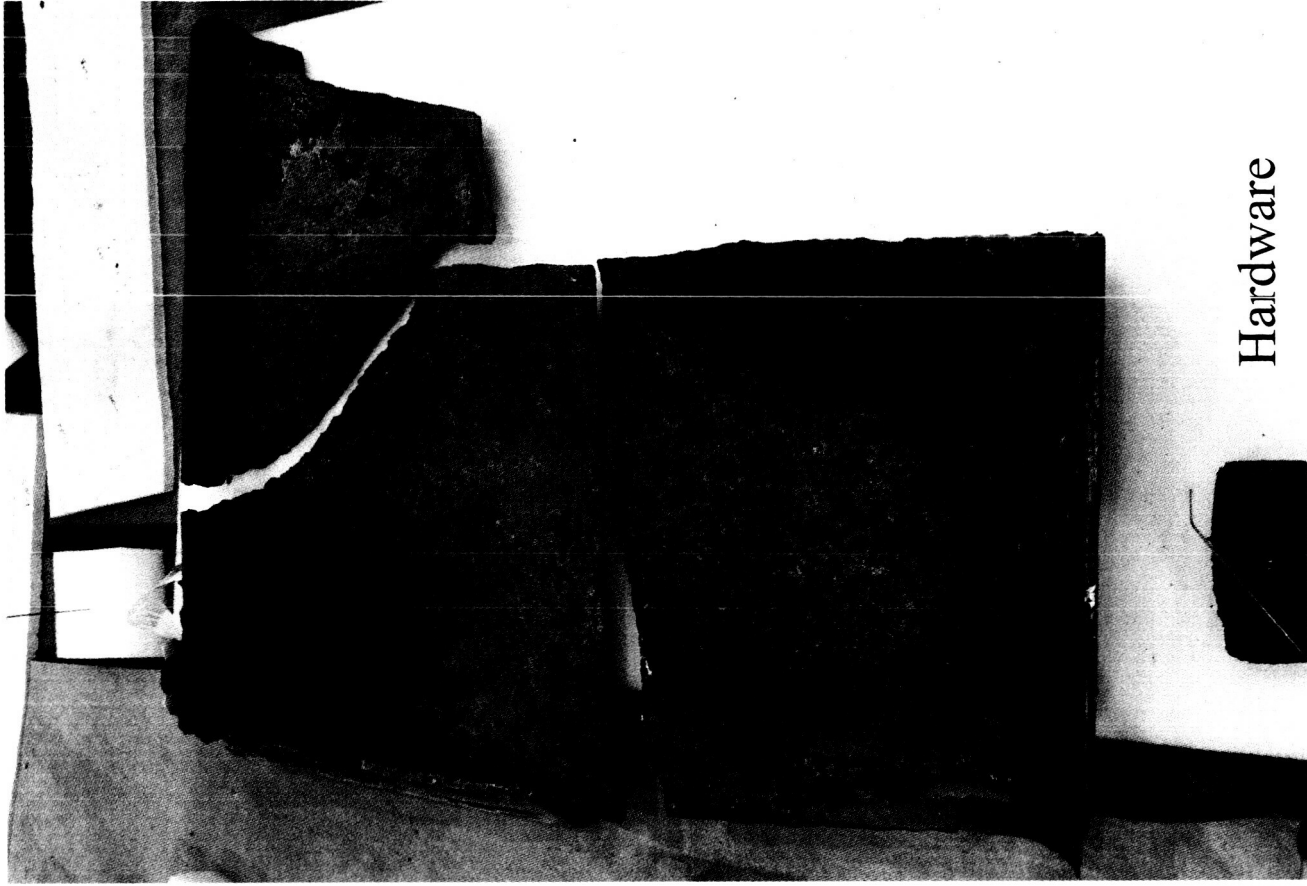
Analysis Technique	Purpose	Why/Advantages
Photography	Photo documentation	Documentation to maintain traceability
Scanning Electron Microscopy – SEM/EDS	Semi-quant elemental composition Back Scattered Imaging	Elements present, identify difference between top and bottom, X-ray mapping.
X-ray Diffraction - XRD	Identify compounds	Identify compounds of crystalline structure
Electron Microprobe	Identify elements	Determine exact composition
Fourier Transform Infra-Red - FTIR	Qualitative organic composition	If organic, aid in identification
ESCA/XPS	Identify inorganic & organic compounds	Aid in tracking of oxidation states, such as oxide; compound identification
Metallography + SEM	Layering of material	Composition through deposit layers
Inductively coupled plasma - ICP	Quantitative elemental composition	Elements present, Quantify bulk composition of sample
Radiography, CT, Ultrasonics	NDI and identification	See through the material, identify differences in materials, identify defects

Analysis Approach Drivers

- **Strategically locate samples and reduce their number** - Radiography
- **Repeatability and Reproducibility** – take two samples of each feature.
- **Identify layering** – Through X-section
- **Identify elemental distribution** – SEM/EDS/X-ray Map, Back Scattered Imaging.
- **Identify compound formation** – X-ray diffraction and XPS
- **Quantify deposit chemistry** – Microprobe calibrated by standards
- **Relate the chemistry to Wing Leading edge source** - Accurate atomic ratios of specific elements present in slag obtained from Microprobe analysis identify the leading edge material source
- **Deposit Timeline** – Layering of wing leading edge material identifies the sequence of events
- **Global correlation of all data** – Multiple x-sections (located across multiple RCC panels) correlated with radiographic results to yield consistent layering information and thus the global sequence of events



Radiographic Image



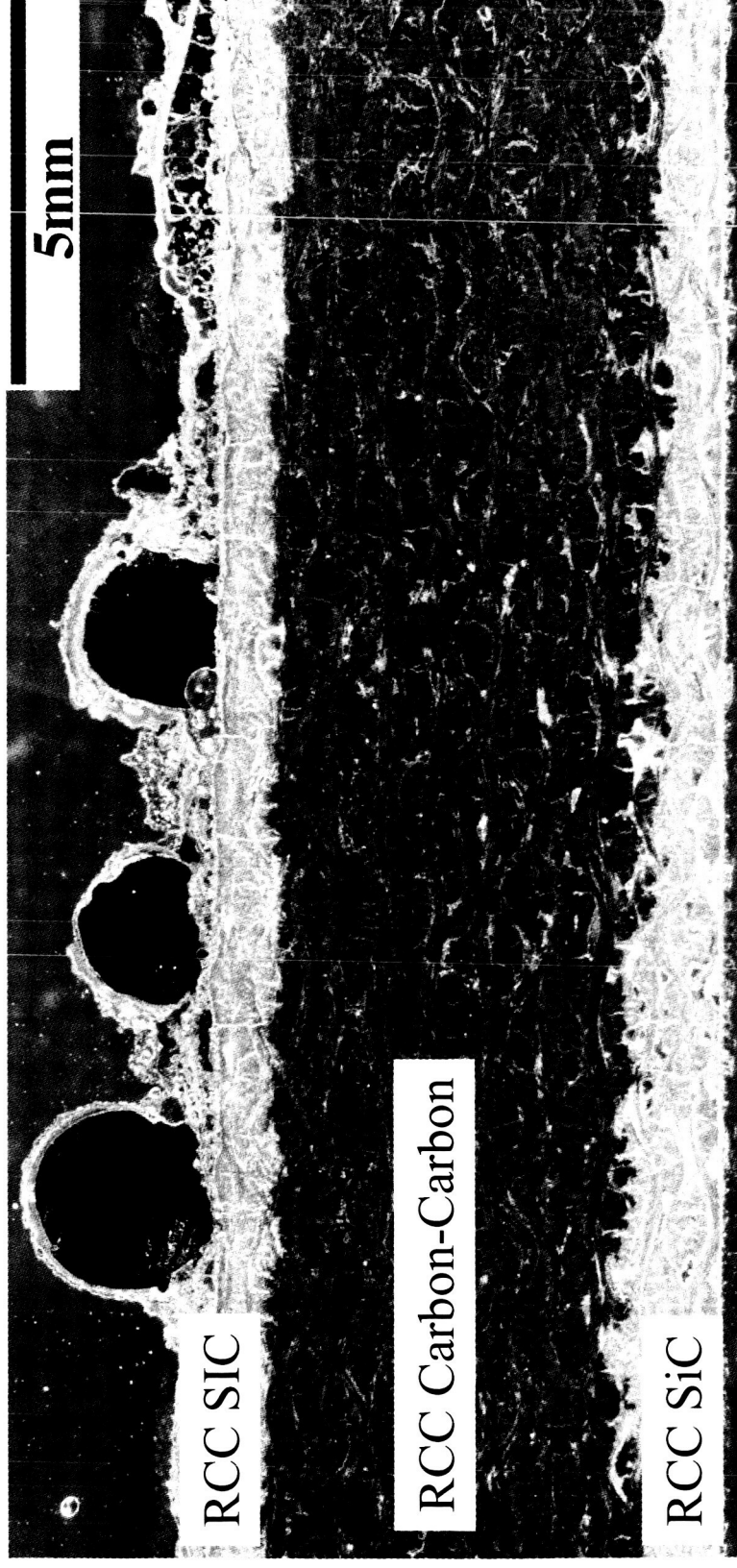
Hardware

Sample Location in Panel LH #8



Sample 3 X-section

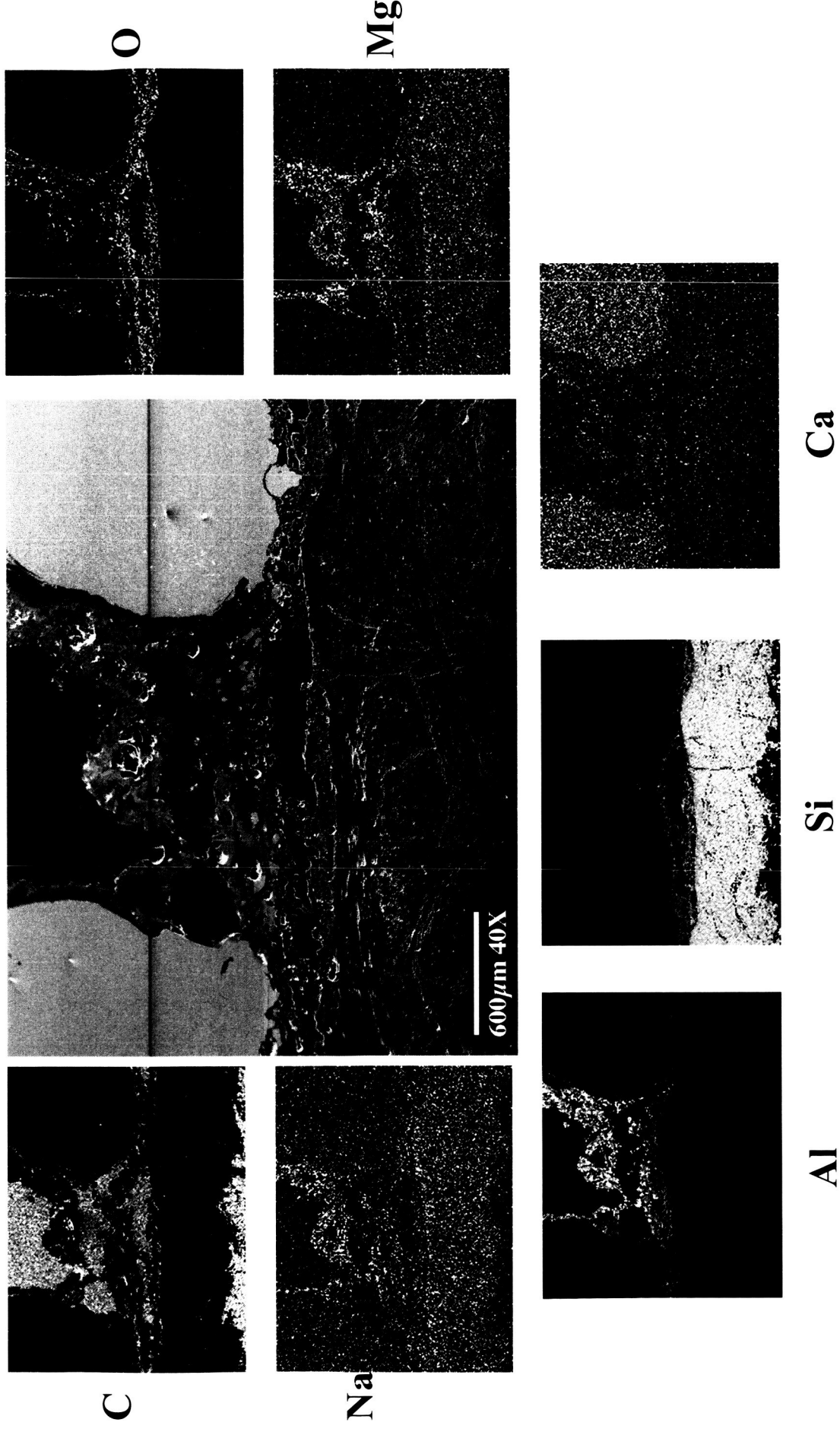
Inside Surface



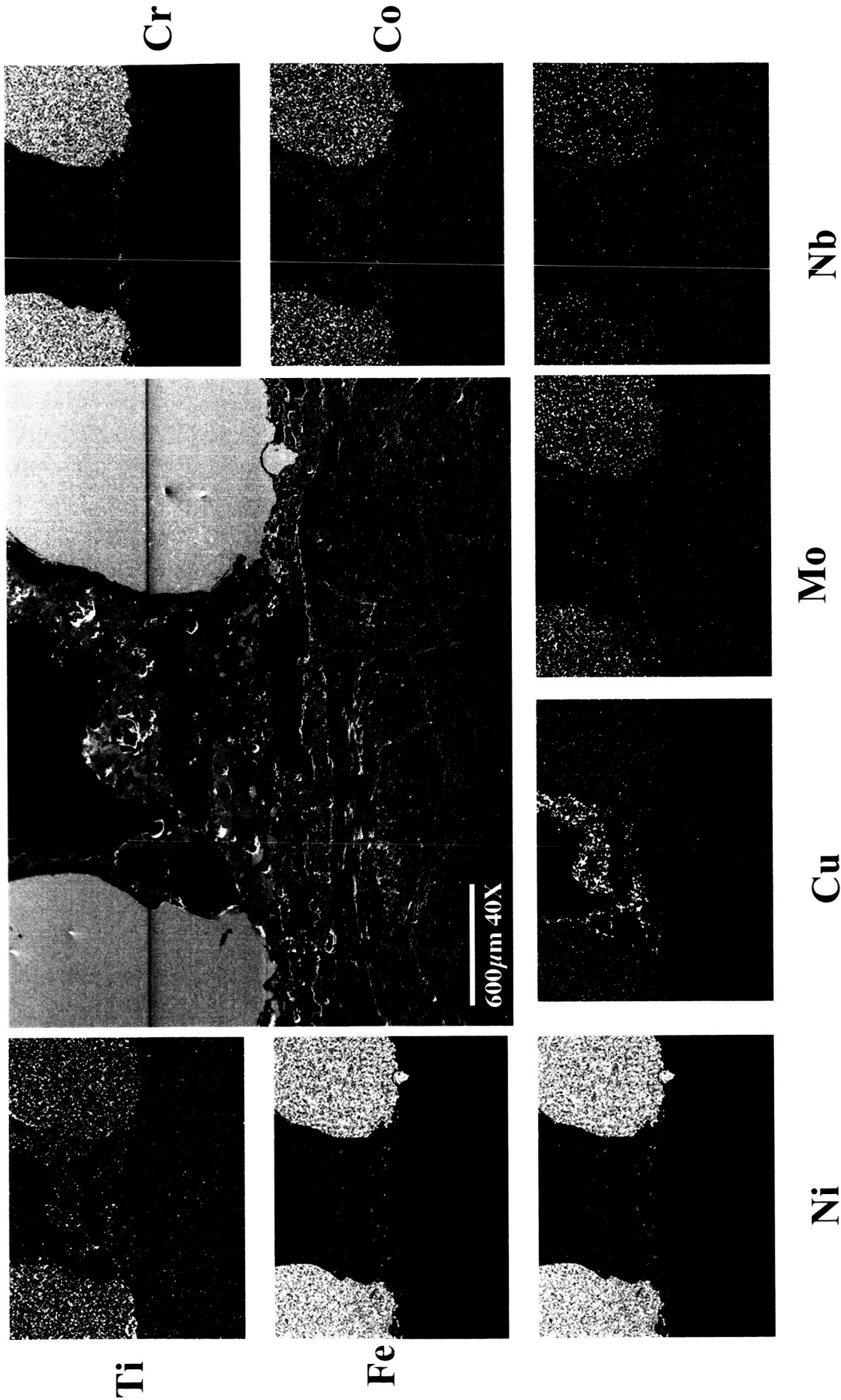
Outside Surface

Successful in cutting through the feature of interest guided by radiography ²³

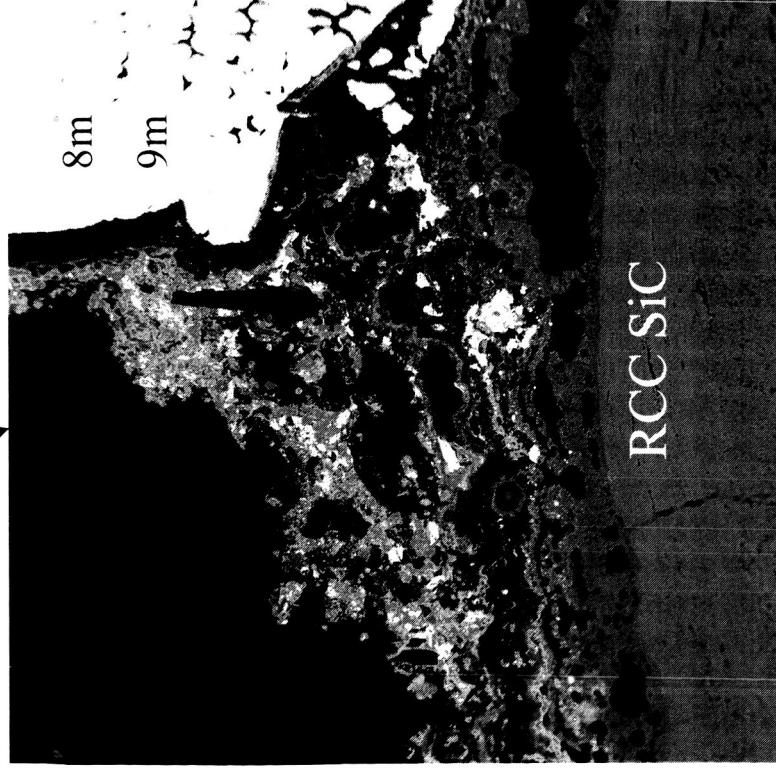
Elemental X-ray Dot Map - SEM



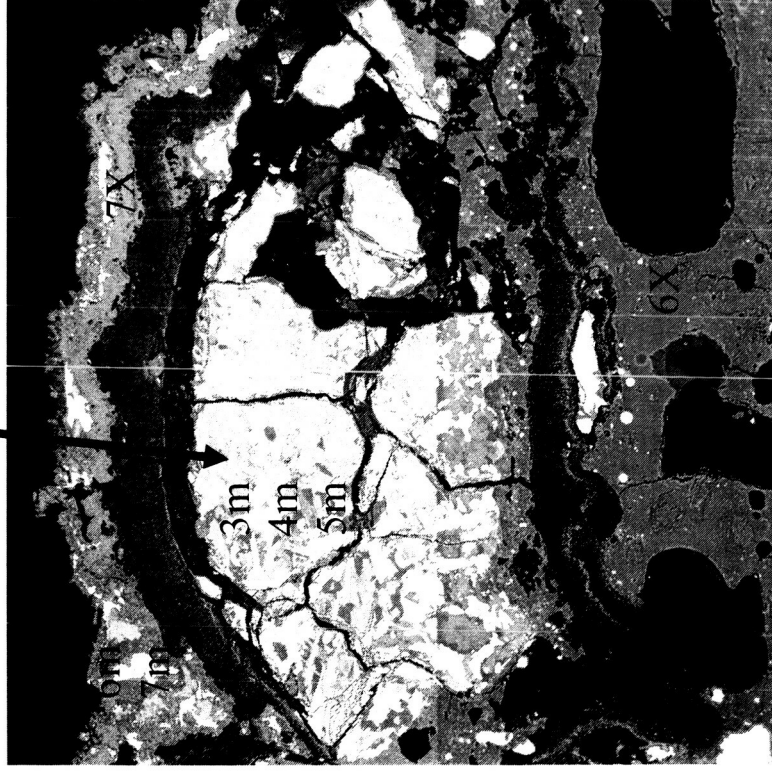
Elemental X-ray Dot Map - SEM



Backscattered Electron Imaging and Microprobe chemical analysis



M = Metallic
X = Oxide



BackScattered Images showing contrast between Metals and Oxides

Quantitative Chemical Analysis in Atomic %

Point	Cr	Ti	Mo	Nb	Ni	Fe	Co	Cu	Si	Al	Mg			
3m	0.44	0.02	0.01	0.02	29.9	2.27	0.1	4.98	3.12	59.14	0			
4m	5	0.01	0.21	0.03	7.34	13.81	0.13	0.53	6.25	66.68	0.01			
5m	4.37	0.02	0.13	0.03	2.48	10.87	0.08	1.23	10.95	69.84	0			
6m	0.14	0	0	0	12.21	4.73	0.13	1.19	1.7	79.9	0			
7m	0.13	0	0	0	26.67	0.57	0.04	10.74	0.61	61.23	0			
8m	18.53	0.16	1.19	0.52	46.65	26.91	0.39	0.14	2.25	3.26	0			
9m	1.79	9.41	2.11	82.74	2.5	1.4	0.03	0.03	0	0	0			
Point	Na	Mg	Al	Si	Ni	Fe	Co	Cu	Cr	Ti	Ca	Mo	Nb	O
5X	0.06	0.03	22.87	1.65	0.86	0.57	0	0.14	0.63	0	0.01	0	0	73.19
6X	0.16	0.21	3.95	28.57	0.1	0.14	0	0	0.29	0.01	0.05	0.01	0	66.51
7X	0.01	0.37	40.49	13.15	0.24	0.12	0	0.4	0.07	0.01	0.02	0	0	45.12

Interpretation Criteria - Examples

- **How to identify specific alloys in the deposit?**
 - A286 or IN601, IN718, IN625 can be distinguished based on (Ni/Fe) ratio and evidence and amounts of Mo, Nb, Co and Ti.
 - 2024 can be identified by presence of metallic Al + Cu, Al_2O_3 + Cu.
- **How to identify Cerachrome in deposit?**
 - Cerachrome is approximately 43% Al_2O_3 53% SiO_2 3% Cr_2O_3 .
 - It can be identified from a combination of back-scattered imaging, color, x-ray diffraction and presence and quantification of Al, Si, O, & Cr.
- **How to identify SiO_2 from Tile?**
 - SiO_2 from tile will not have with other elements as in cerachrome. It could still pick up a coating of alumina then morphological features will be used to distinguish.

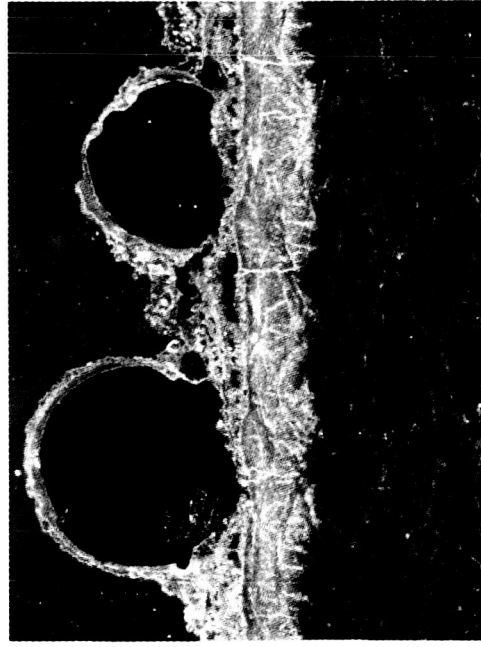
Interpretation

Point	Analysis Notes	Source Identification (Major component in Bold)
3m	Al+Ni, some Fe+Cr+Ti+Cu, minimal Mo+Nb	2024Al , IN601, SiC
4m	Al+Fe, Some Ni+Cr+Ti+Cu, minimal Mo+Nb	2024Al , IN601, SiC
5m	Al+Si+Fe, some Fe+Cr+Ti+Cu, minimal Mo+Nb	2024Al , IN601, SiC
6m	Al+Ni, some Fe+Cr+Si, no Ti+Mo+Nb	2024Al , IN601, SiC
7m	Al+Ni+Cu, Some Fe+Cr+Si, no Ti+Mo+Nb	2024Al , IN601, SiC
8m	Ni+Fe+Cr, some Si+Al+Ti+Mo+Nb, Ni/Fe=1.7	IN718 , 2024Al , SiC
9m	Nb+Ti, some Ni+Fe+Cr	IN718 , 2024Al , SiC
Point		
5X	Alumina+Cu, Some Silica +Cr	2024Al , Cerachrome
6X	Silica+Na, Some alumina+Cr	Type A coating
7X	Alumina+Cu+Silica+Na+Cr, some metallic Al	2024Al , Cerachrome, Type A

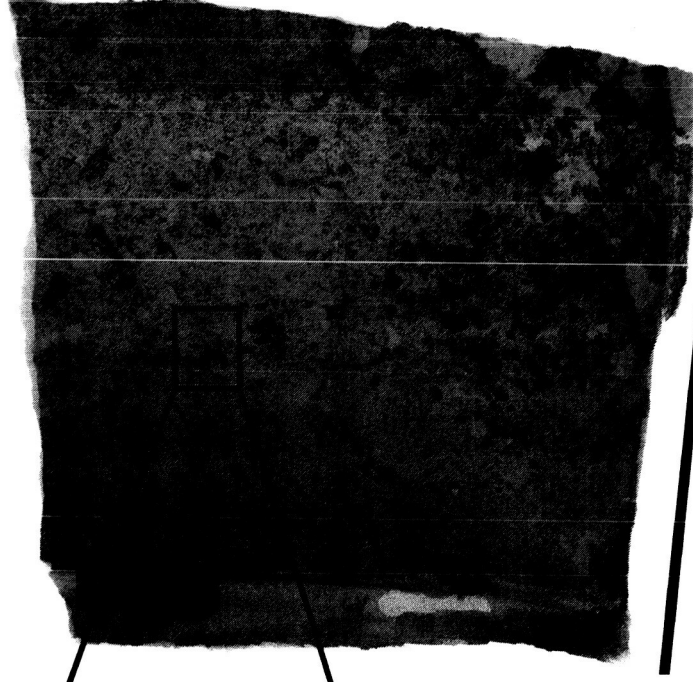
No A286 observed consistently

Left Wing RCC #8 - Slag Feature

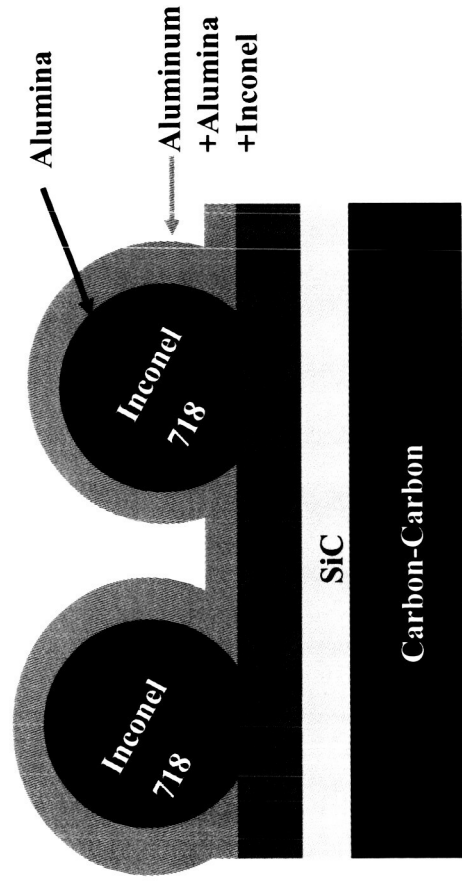
Spheroids



Slag Item 2200, Sample 6C1

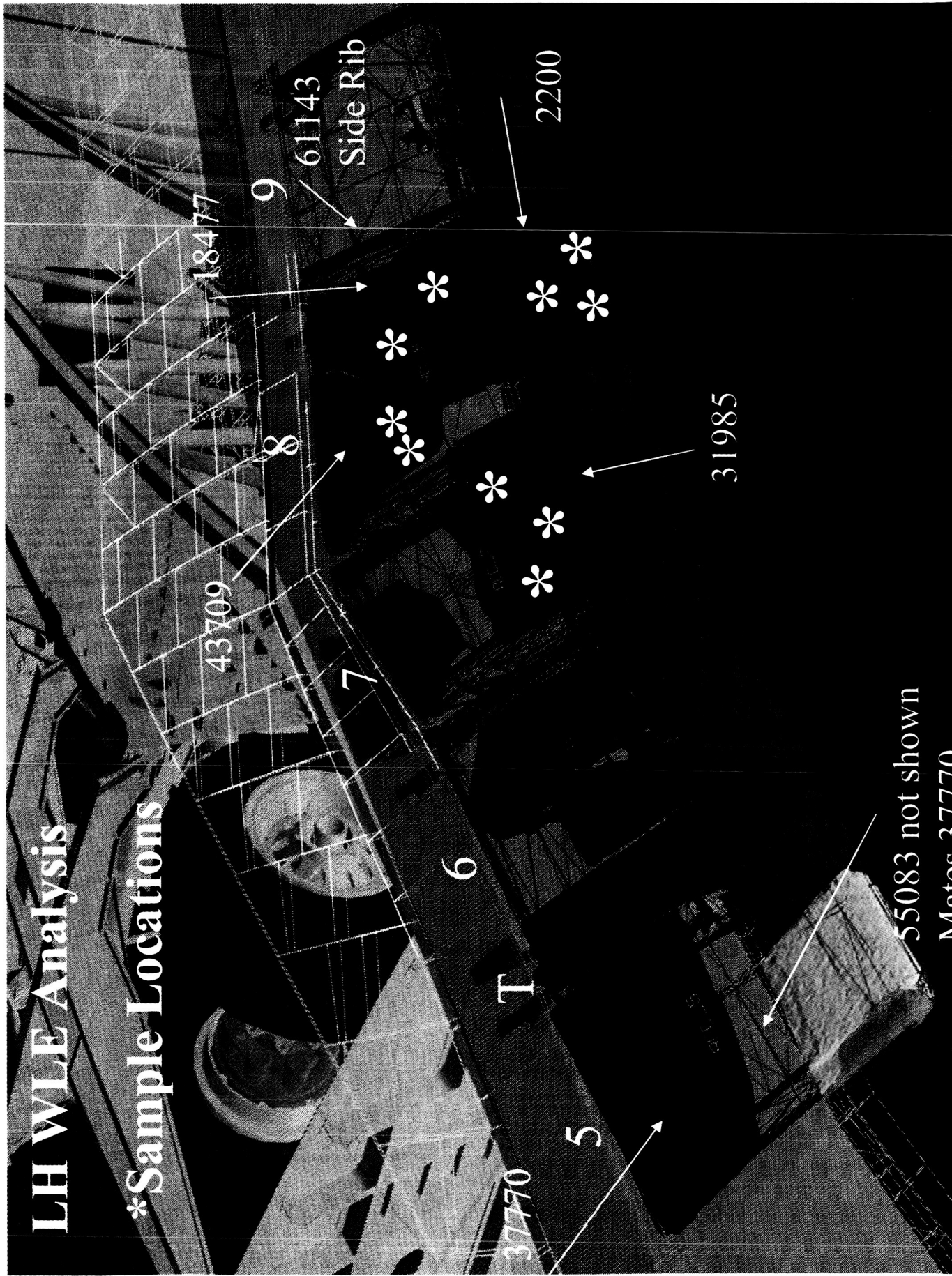


Radiograph of Slag Item 2200



LH WLE Analysis

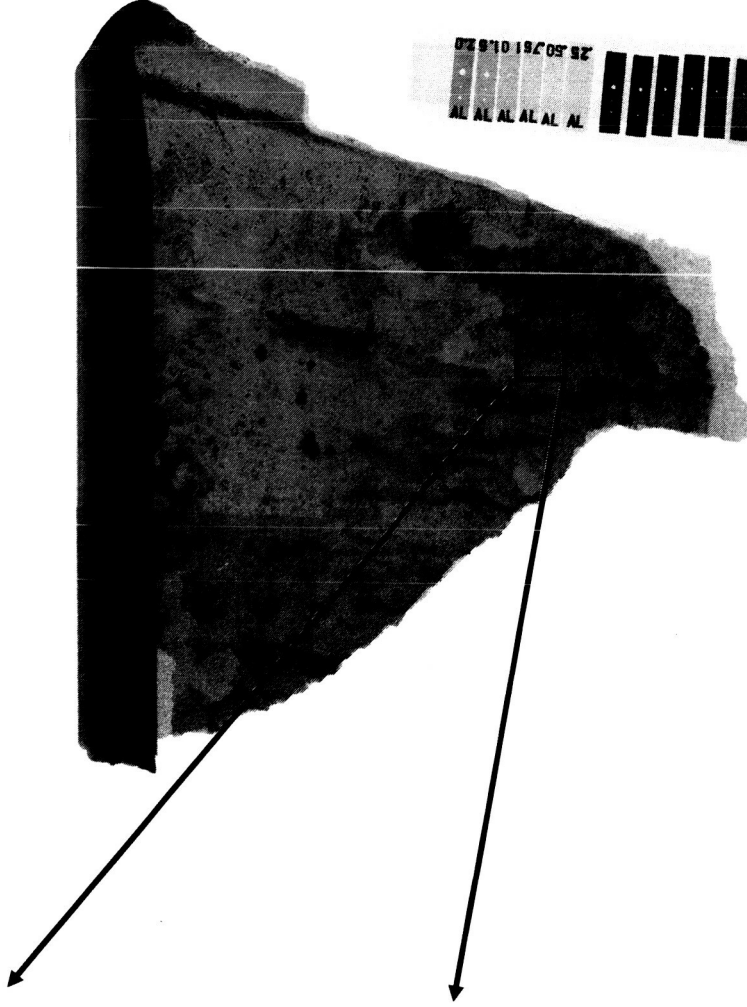
*Sample Locations



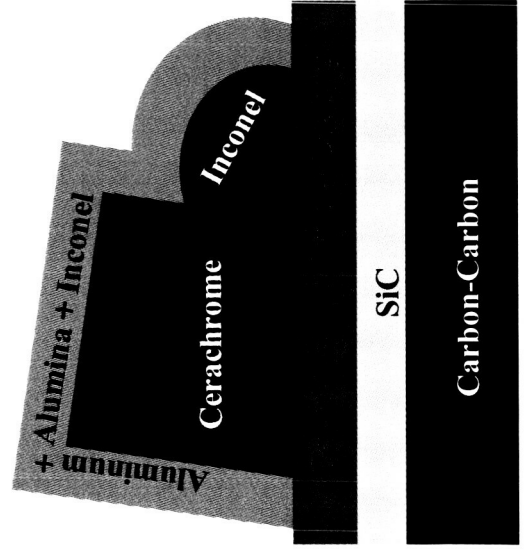
Left Wing RCC #8 - Slag Feature Thick Tear Shaped



Slag Item 43709, Sample 2A1



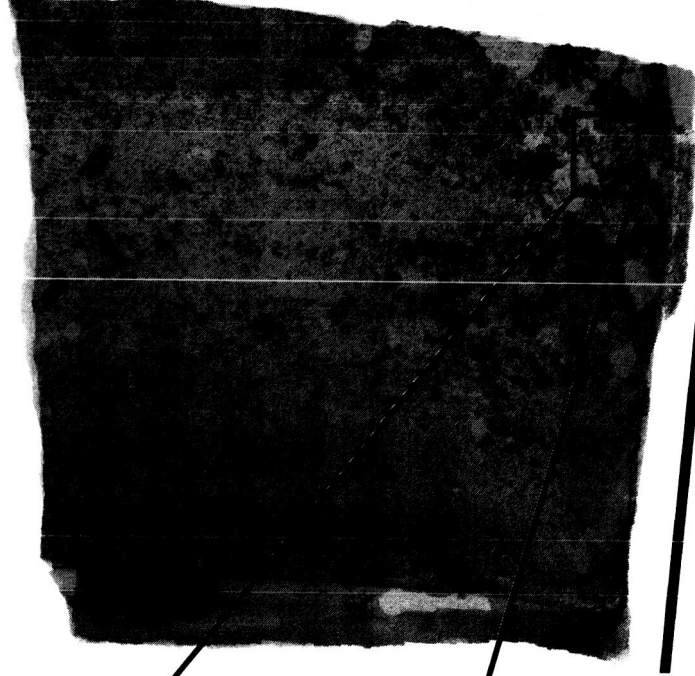
Radiograph of Item 43709



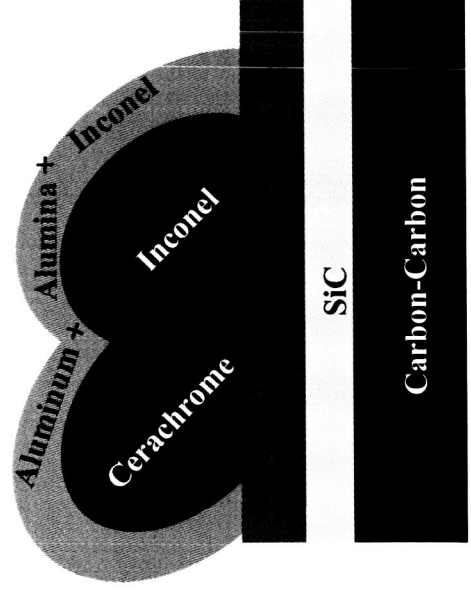
Left Wing RCC #8 - Slag Feature Thick Globules



Slag Item 2200, Sample 6A1

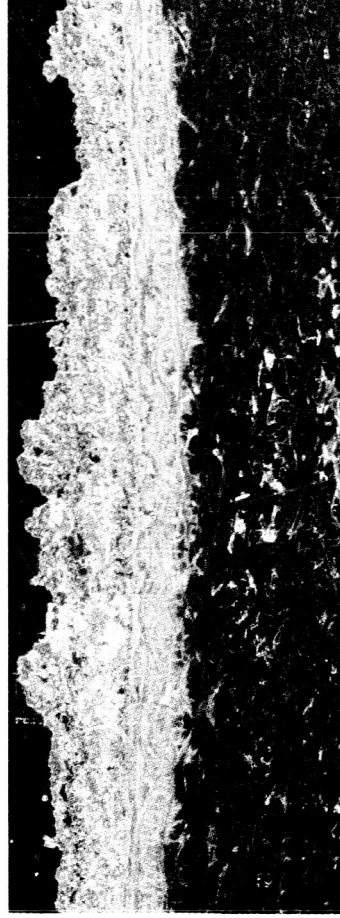


Radiograph of Item 2200

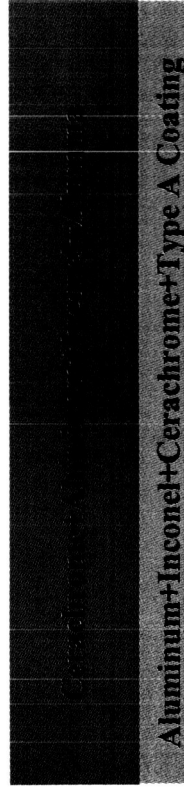


Right Wing RCC #8 - Slag Feature

Uniform Deposit

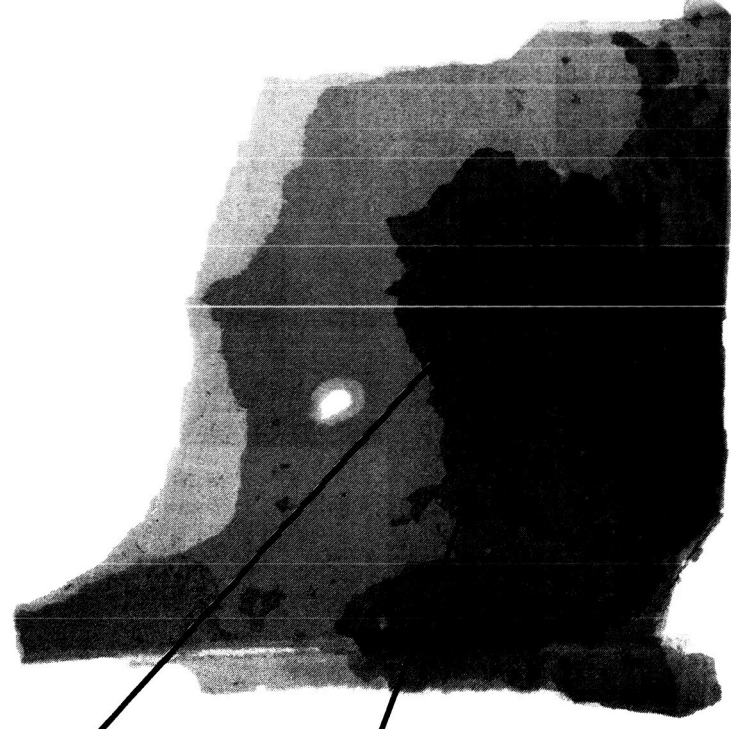


Slag Item 16523, Sample 4A1



SiC

Carbon-Carbon



Radiograph of Item 16523

RCC Slag Significant Findings

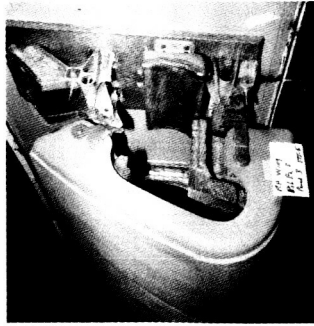
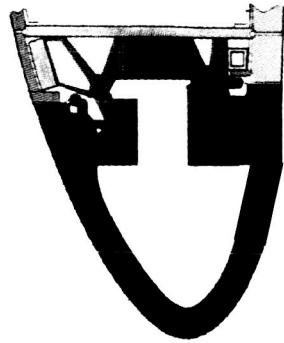
LH RCC #8

- Cerachrome + Inconel in first deposited layers
 - Melting of spanner/foil/fittings + Insulator
- Aluminum deposition secondary event

Slag layering suggests plasma impingement location

Slag distribution & shape suggests plasma flow direction and deposition duration

- No indication of stainless steel spar fittings (A286) in slag
 - Breach location away from spar fittings
- Large amounts of melted ceramic cerachrome insulator
 - High temperature >3200°F

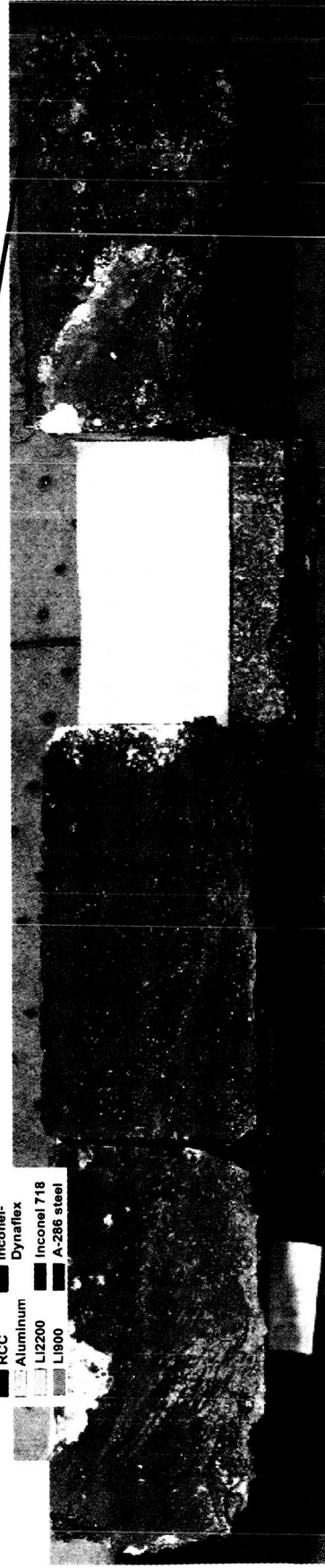


- RCC
- Aluminum
- Li2200
- Li900
- Inconel-Dynaflex
- Inconel 718
- A-286 steel

Reconstructed View

LH CP Panel 9 Tiles, lower

Horse Collar Fabric Deposit



C P 8

Tile Slumping

Insert

16692

50338

Molten Slag on Tile

22571

57754

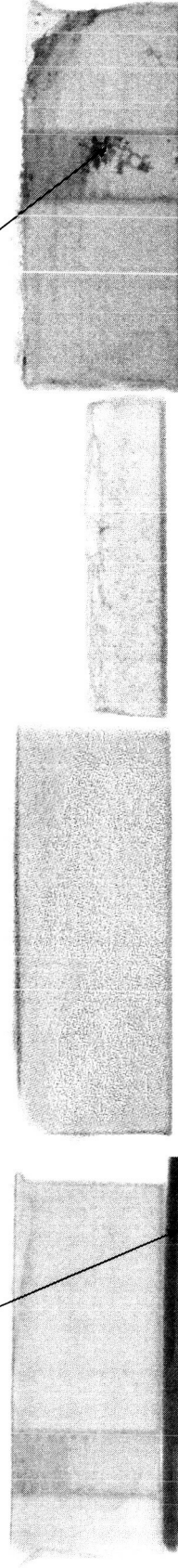
Spar

RCC

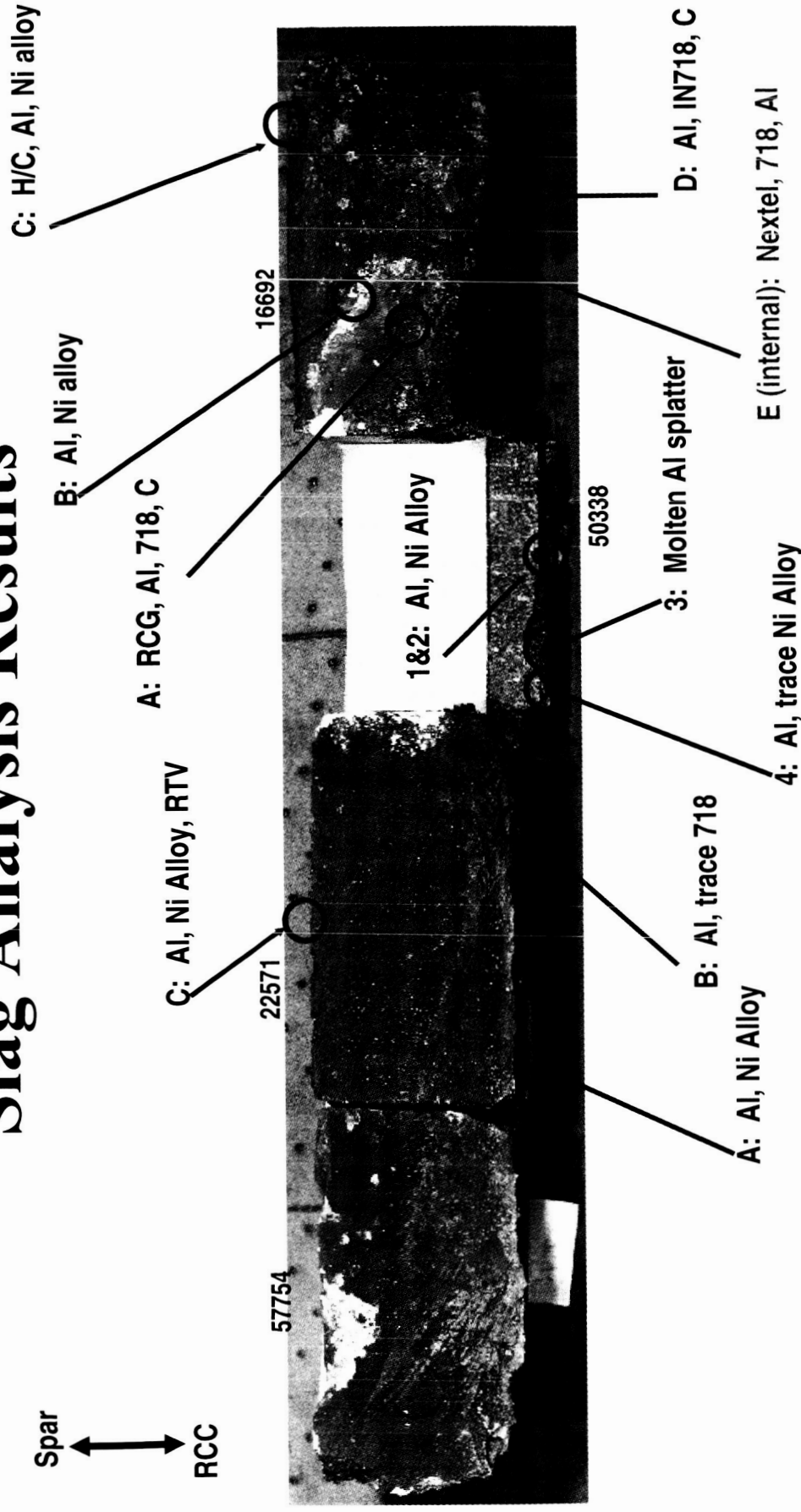
Carrier Panel

Realtime X-ray, Sidewall View

High-Z material



Reconstructed View LH Carrier Panel 9 Tiles, Lower Slag Analysis Results



These findings suggest flow of material from inside the RCC out through the upper and lower CP locations.

Proposed Breach Location & Plasma Flow Based On Slag Results

